

$V_{CE} = 3300 \text{ V}$
 $I_C = 800 \text{ A}$

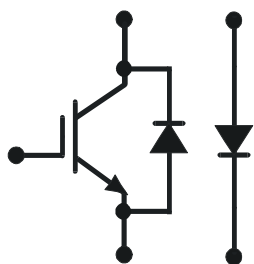


ABB HiPak™

IGBT Module

5SNE 0800E330100

PRELIMINARY

Doc. No. 5SYA1562-01 July 07

- Low-loss, rugged SPT chip-set
- Smooth switching SPT chip-set for good EMC
- Industry standard package
- High power density
- AlSiC base-plate for high power cycling capability
- AlN substrate for low thermal resistance



Maximum rated values ¹⁾

Parameter	Symbol	Conditions	min	max	Unit
Collector-emitter voltage	V_{CES}	$V_{GE} = 0 \text{ V}$, $T_{vj} \geq 25 \text{ °C}$		3300	V
DC collector current	I_C	$T_c = 80 \text{ °C}$		800	A
Peak collector current	I_{CM}	$t_p = 1 \text{ ms}$, $T_c = 80 \text{ °C}$		1600	A
Gate-emitter voltage	V_{GES}		-20	20	V
Total power dissipation	P_{tot}	$T_c = 25 \text{ °C}$, per switch (IGBT)		7700	W
DC forward current	I_F	Either diode		800	A
Peak forward current	I_{FRM}			1600	A
Surge current	I_{FSM}	$V_R = 0 \text{ V}$, $T_{vj} = 125 \text{ °C}$, $t_p = 10 \text{ ms}$, half-sinewave, either diode		8000	A
IGBT short circuit SOA	t_{psc}	$V_{CC} = 2500 \text{ V}$, $V_{CEMCHIP} \leq 3300 \text{ V}$ $V_{GE} \leq 15 \text{ V}$, $T_{vj} \leq 125 \text{ °C}$		10	μs
Isolation voltage	V_{isol}	$t = 1 \text{ min}$, $f = 50 \text{ Hz}$		6000	V
Junction temperature	T_{vj}			150	°C
Junction operating temperature	$T_{vj(op)}$		-40	125	°C
Case temperature	T_c		-40	125	°C
Storage temperature	T_{stg}		-40	125	°C
Mounting torques ²⁾	M_s	Base-heatsink, M6 screws	4	6	Nm
	M_{t1}	Main terminals, M8 screws	8	10	
	M_{t2}	Auxiliary terminals, M4 screws	2	3	

¹⁾ Maximum rated values indicate limits beyond which damage to the device may occur per IEC 60747

²⁾ For detailed mounting instructions refer to ABB Document No. 5SYA2039

ABB Switzerland Ltd, Semiconductors reserves the right to change specifications without notice.



IGBT characteristic values ³⁾

Parameter	Symbol	Conditions	min	typ	max	Unit	
Collector (-emitter) breakdown voltage	V _{(BR)CES}	V _{GE} = 0 V, I _C = 10 mA, T _{vj} = 25 °C	3300			V	
Collector-emitter ⁴⁾ saturation voltage	V _{CE sat}	I _C = 800 A, V _{GE} = 15 V	T _{vj} = 25 °C	2.7	3.1	3.4	V
			T _{vj} = 125 °C	3.5	3.8	4.3	V
Collector cut-off current	I _{CES}	V _{CE} = 3300 V, V _{GE} = 0 V	T _{vj} = 25 °C			8	mA
			T _{vj} = 125 °C			80	mA
Gate leakage current	I _{GES}	V _{CE} = 0 V, V _{GE} = ±20 V, T _{vj} = 125 °C	-500		500	nA	
Gate-emitter threshold voltage	V _{GE(TO)}	I _C = 160 mA, V _{CE} = V _{GE} , T _{vj} = 25 °C	5.5		7.5	V	
Gate charge	Q _{ge}	I _C = 800 A, V _{CE} = 1800 V, V _{GE} = -15 V .. 15 V		8.07		μC	
Input capacitance	C _{ies}	V _{CE} = 25 V, V _{GE} = 0 V, f = 1 MHz, T _{vj} = 25 °C		125		nF	
Output capacitance	C _{oes}			7.71			
Reverse transfer capacitance	C _{res}			1.48			
Turn-on delay time	t _{d(on)}	V _{CC} = 1800 V, I _C = 800 A, R _G = 2.2 Ω,	T _{vj} = 25 °C	525		ns	
			T _{vj} = 125 °C	525			
Rise time	t _r	V _{GE} = ±15 V, L _σ = 100 nH, inductive load	T _{vj} = 25 °C	190		ns	
			T _{vj} = 125 °C	200			
Turn-off delay time	t _{d(off)}	V _{CC} = 1800 V, I _C = 800 A, R _G = 2.2 Ω,	T _{vj} = 25 °C	1060		ns	
			T _{vj} = 125 °C	1210			
Fall time	t _f	V _{GE} = ±15 V, L _σ = 100 nH, inductive load	T _{vj} = 25 °C	340		ns	
			T _{vj} = 125 °C	460			
Turn-on switching energy	E _{on}	V _{CC} = 1800 V, I _C = 800 A, V _{GE} = ±15 V, R _G = 2.2 Ω, L _σ = 100 nH, inductive load	T _{vj} = 25 °C	1000		mJ	
			T _{vj} = 125 °C	1380			
Turn-off switching energy	E _{off}	V _{CC} = 1800 V, I _C = 800 A, V _{GE} = ±15 V, R _G = 2.2 Ω, L _σ = 100 nH, inductive load	T _{vj} = 25 °C	880		mJ	
			T _{vj} = 125 °C	1250			
Short circuit current	I _{SC}	t _{pSC} ≤ 10 μs, V _{GE} = 15 V, T _{vj} = 125 °C, V _{CC} = 2500 V, V _{CEM CHIP} ≤ 3300 V		3300		A	
Module stray inductance	L _{σ CE}	Leg 1 + 2 parallel		15		nH	
Resistance, terminal-chip	R _{CC'+EE'}	Leg 1 + 2 parallel	T _C = 25 °C	0.09		mΩ	
			T _C = 125 °C	0.13			

³⁾ Characteristic values according to IEC 60747 – 9⁴⁾ Collector-emitter saturation voltage is given at chip level

Diode characteristic values ⁵⁾

Parameter	Symbol	Conditions	min	typ	max	Unit	
Forward voltage ⁶⁾	V _F	I _F = 800 A	T _{vj} = 25 °C	2.0	2.3	2.6	V
			T _{vj} = 125 °C	2.0	2.35	2.6	
Reverse recovery current	I _{rr}	V _{CC} = 1800 V, I _F = 800 A, V _{GE} = ±15 V, R _G = 2.2 Ω L _σ = 100 nH inductive load	T _{vj} = 25 °C		710		A
	T _{vj} = 125 °C			950			
Recovered charge	Q _{rr}		T _{vj} = 25 °C		500		μC
			T _{vj} = 125 °C		930		
Reverse recovery time	t _{rr}		T _{vj} = 25 °C		850		ns
			T _{vj} = 125 °C		1550		
Reverse recovery energy	E _{rec}		T _{vj} = 25 °C		620		mJ
			T _{vj} = 125 °C		1180		
Stray inductance	L _{σ AC}	Leg 3		30		nH	
Resistance, terminal-chip	R _{AA'+CC'}	Leg 3	T _C = 25 °C		0.18		mΩ
			T _C = 125 °C		0.26		

⁵⁾ Characteristic values according to IEC 60747 – 2⁶⁾ Forward voltage is given at chip level**Thermal properties** ⁷⁾

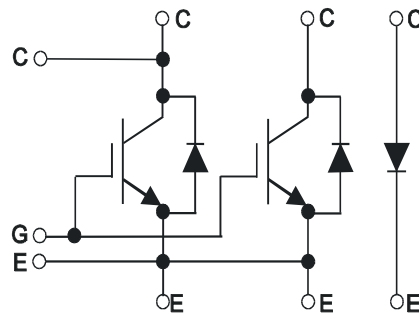
Parameter	Symbol	Conditions	min	typ	max	Unit
IGBT thermal resistance junction to case	$R_{th(j-c)IGBT}$				0.013	K/W
Diode thermal resistance junction to case	$R_{th(j-c)DIODE}$				0.025	K/W
IGBT thermal resistance ²⁾ case to heatsink	$R_{th(c-s)IGBT}$	IGBT per switch, λ grease = $1\text{W/m}^2 \text{ }^{\circ}\text{C}$		0.012		K/W
Diode thermal resistance ²⁾ case to heatsink	$R_{th(c-s)DIODE}$	Diode per switch, λ grease = $1\text{W/m}^2 \text{ }^{\circ}\text{C}$		0.024		K/W

²⁾ For detailed mounting instructions refer to ABB Document No. 5SYA2039**Mechanical properties** ⁷⁾

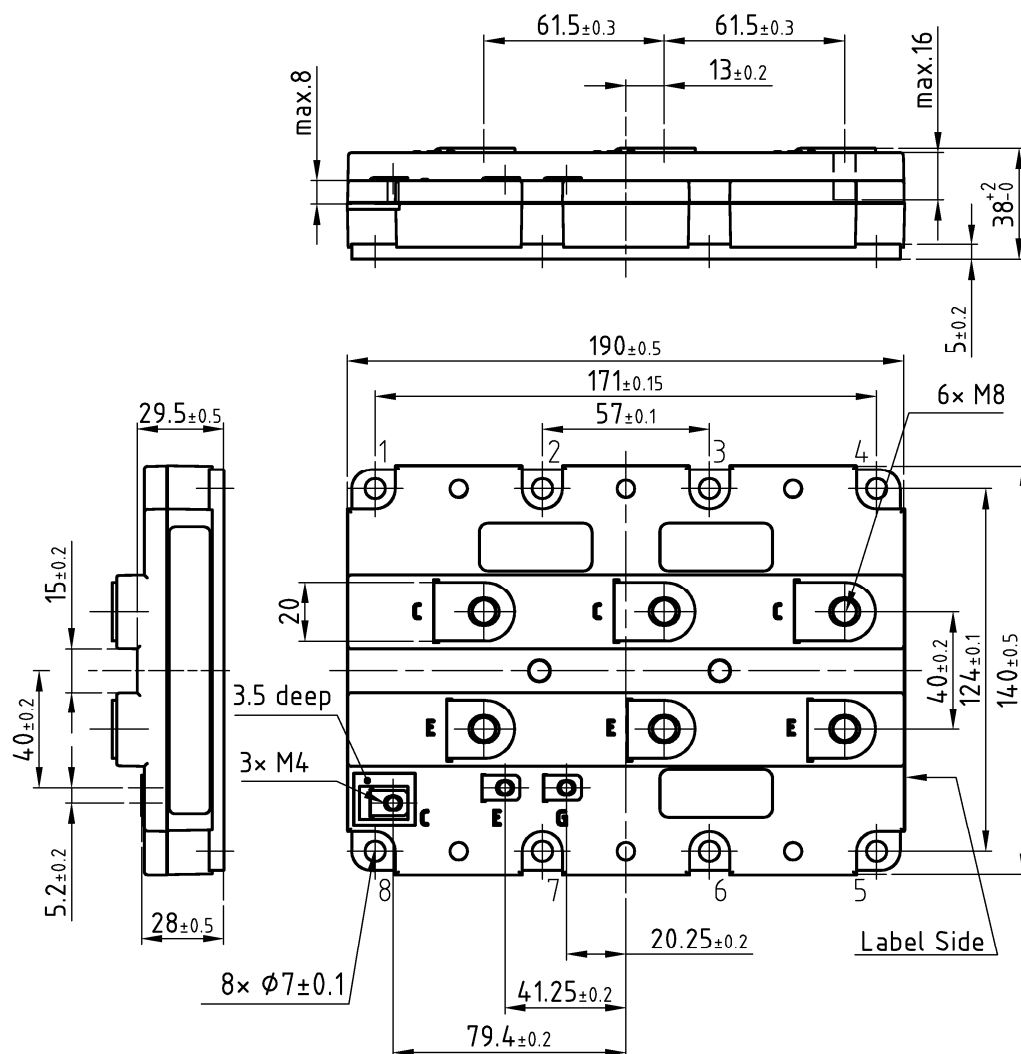
Parameter	Symbol	Conditions	min	typ	max	Unit
Dimensions	$L \times W \times H$	Typical , see outline drawing	$190 \times 140 \times 38$			mm
Clearance distance in air	d_a	according to IEC 60664-1 and EN 50124-1	Term. to base:	23		mm
			Term. to term:	19		
Surface creepage distance	d_s	according to IEC 60664-1 and EN 50124-1	Term. to base:	33		mm
			Term. to term:	32		
Mass	m			1380		g

⁷⁾ Thermal and mechanical properties according to IEC 60747 – 15

Electrical configuration



Outline drawing ²⁾



Note: all dimensions are shown in mm

²⁾ For detailed mounting instructions refer to ABB Document No. 5SYA2039

This is an electrostatic sensitive device, please observe the international standard IEC 60747-1, chap. IX.
This product has been designed and qualified for Industrial Level.

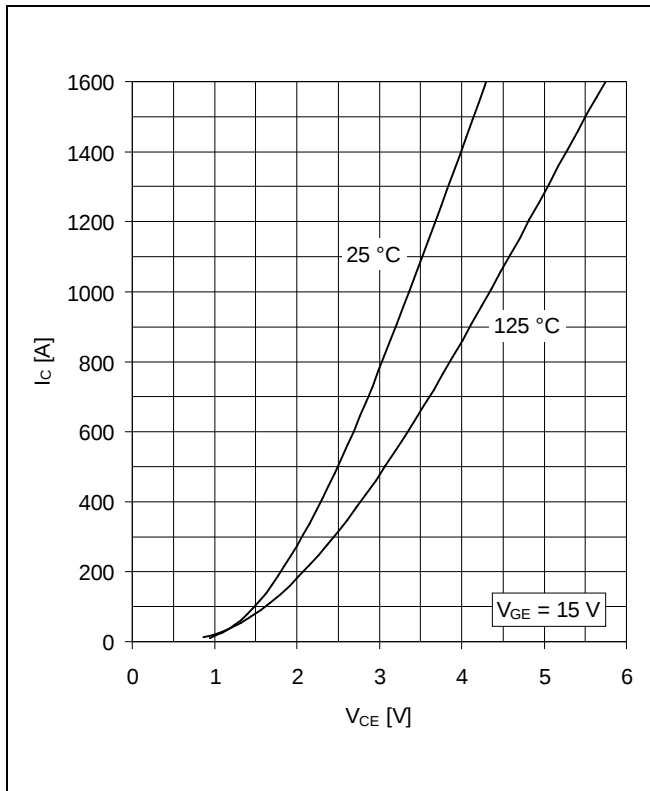


Fig. 1 Typical on-state characteristics, chip level

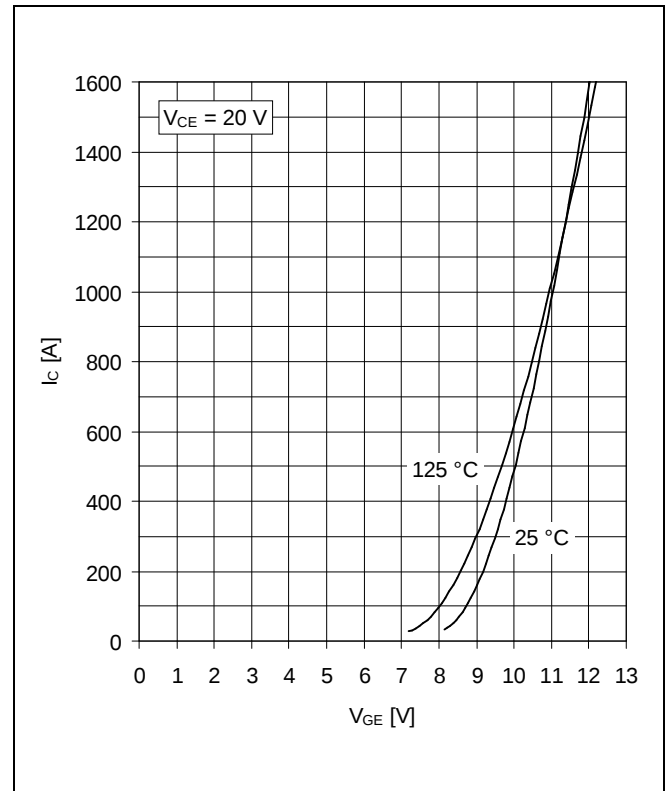


Fig. 2 Typical transfer characteristics, chip level

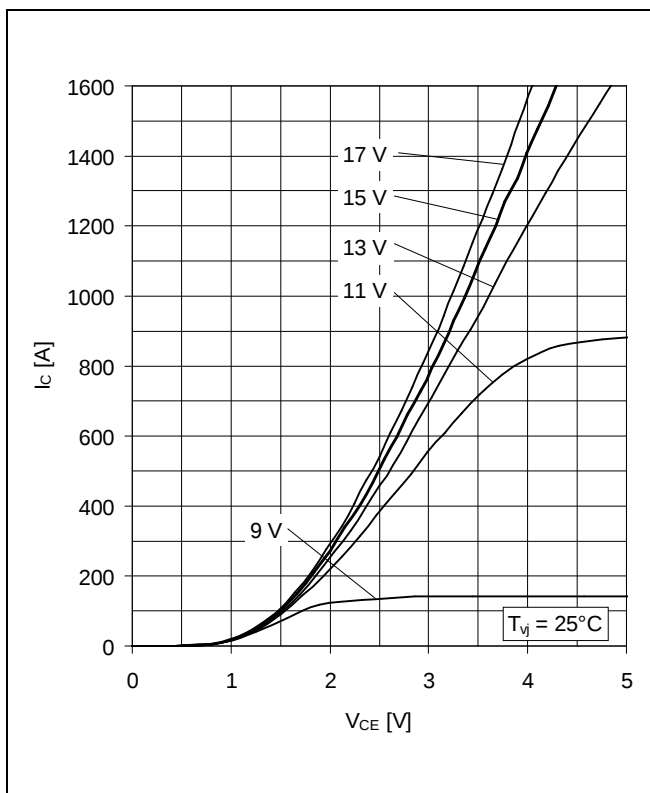


Fig. 3 Typical output characteristics, chip level

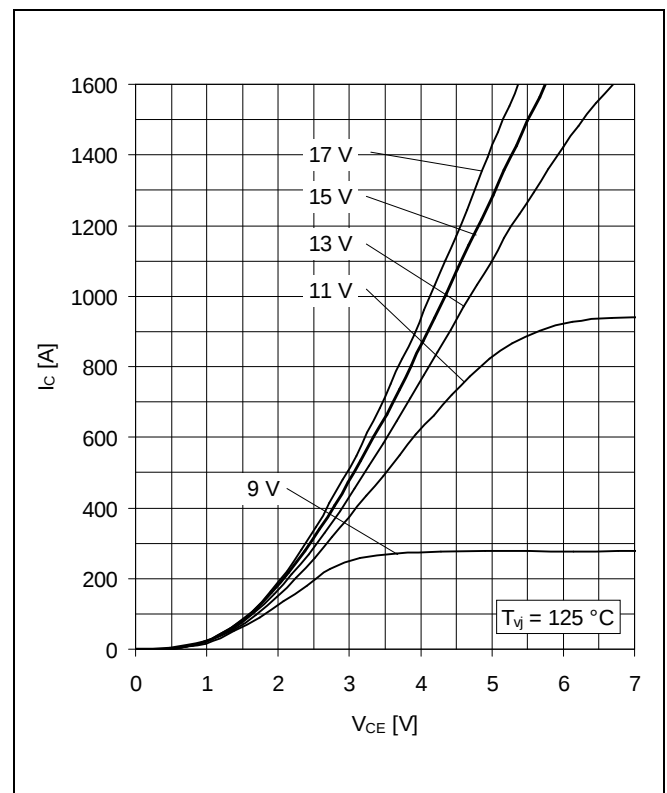


Fig. 4 Typical output characteristics, chip level

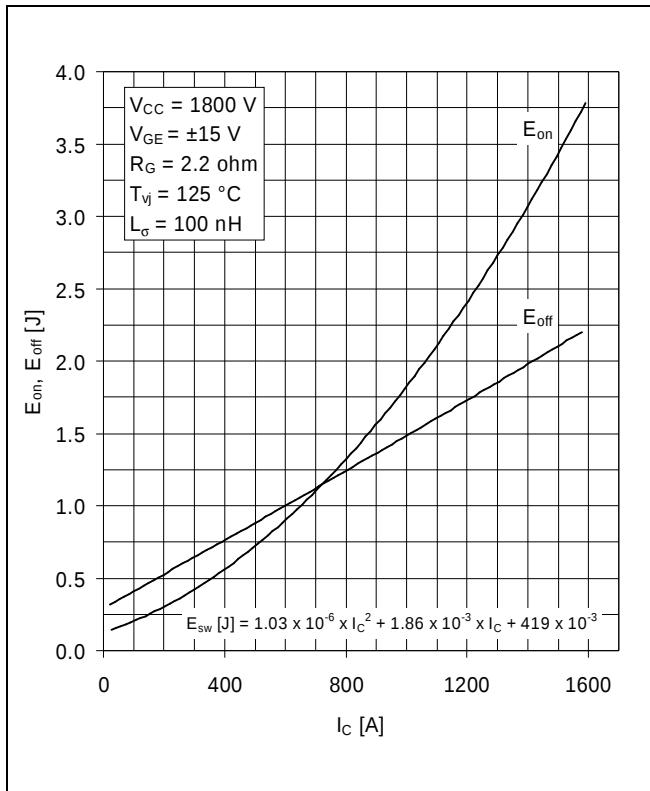


Fig. 5 Typical switching energies per pulse vs collector current

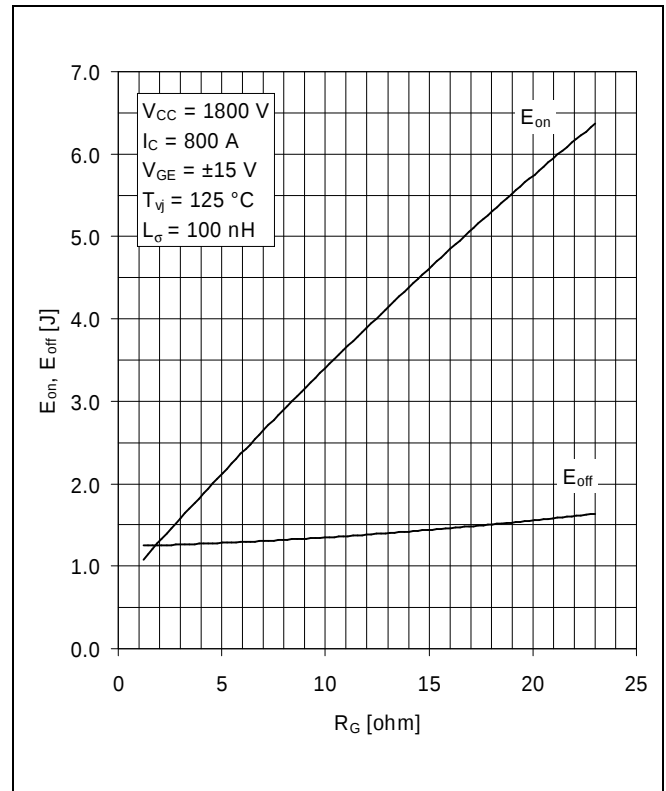


Fig. 6 Typical switching energies per pulse vs gate resistor

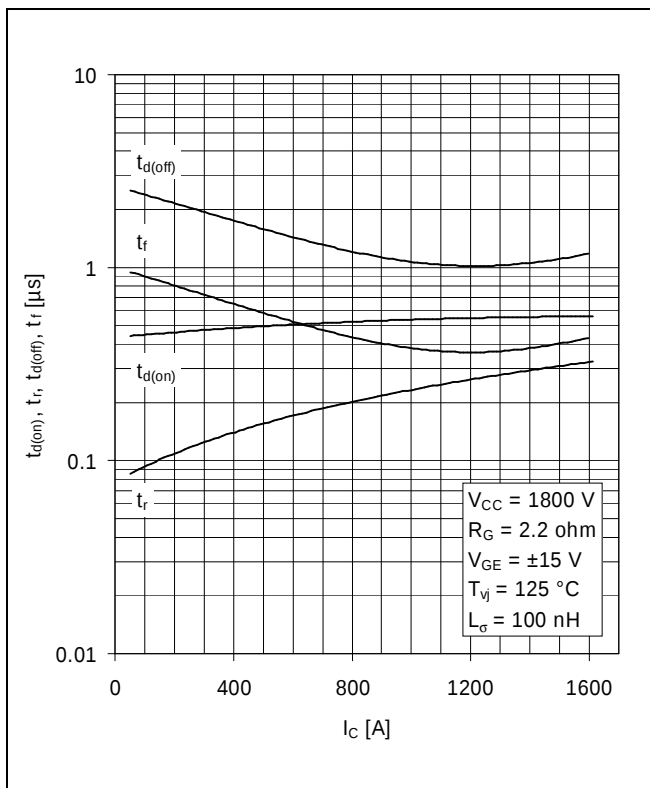


Fig. 7 Typical switching times vs collector current

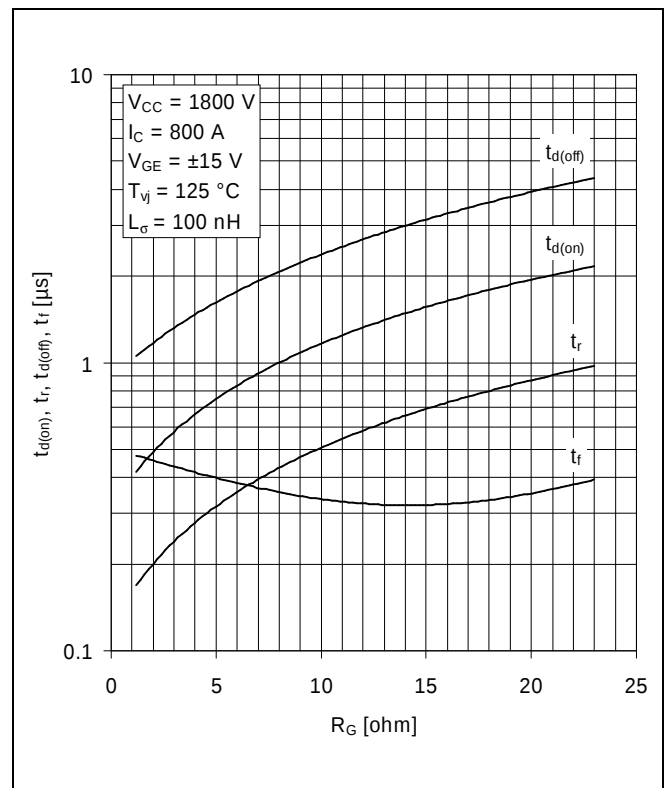


Fig. 8 Typical switching times vs gate resistor

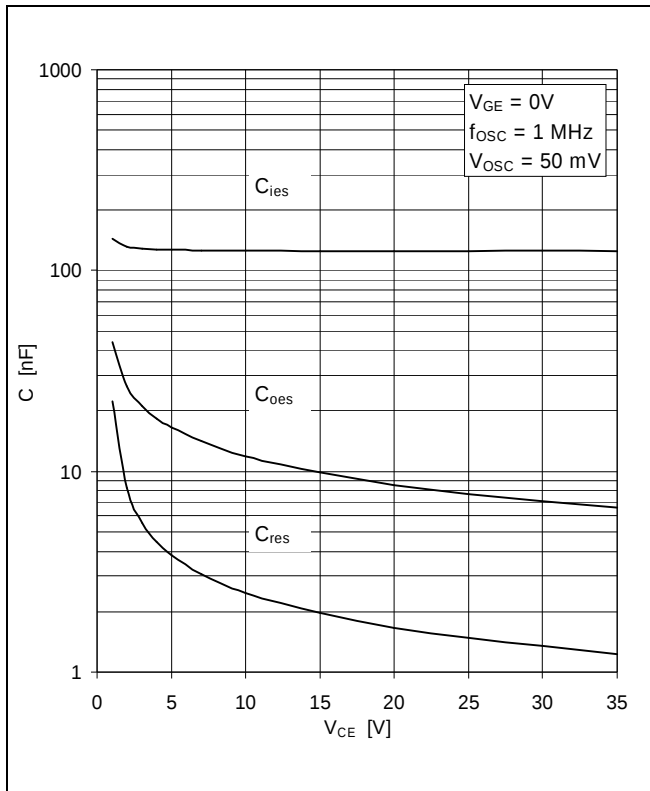


Fig. 9 Typical capacitances vs collector-emitter voltage

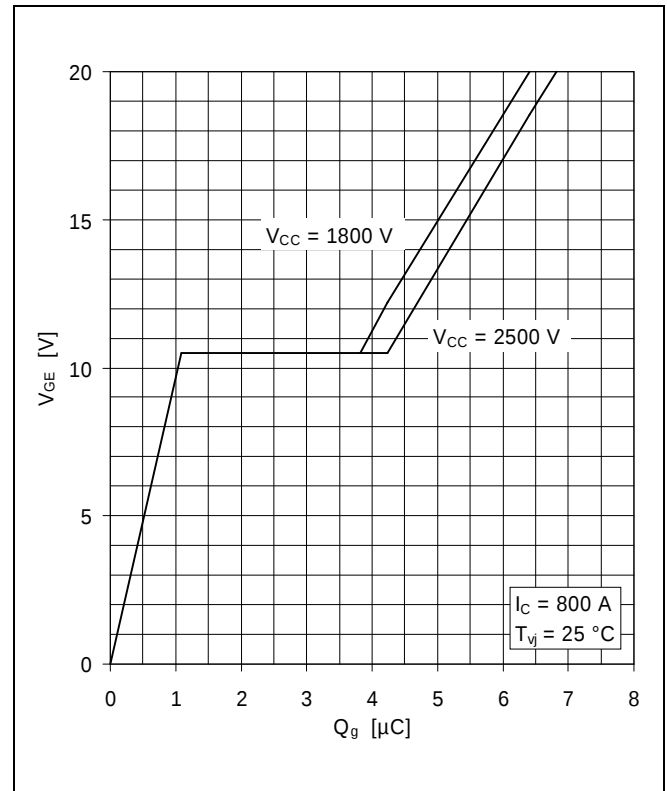


Fig. 10 Typical gate charge characteristics

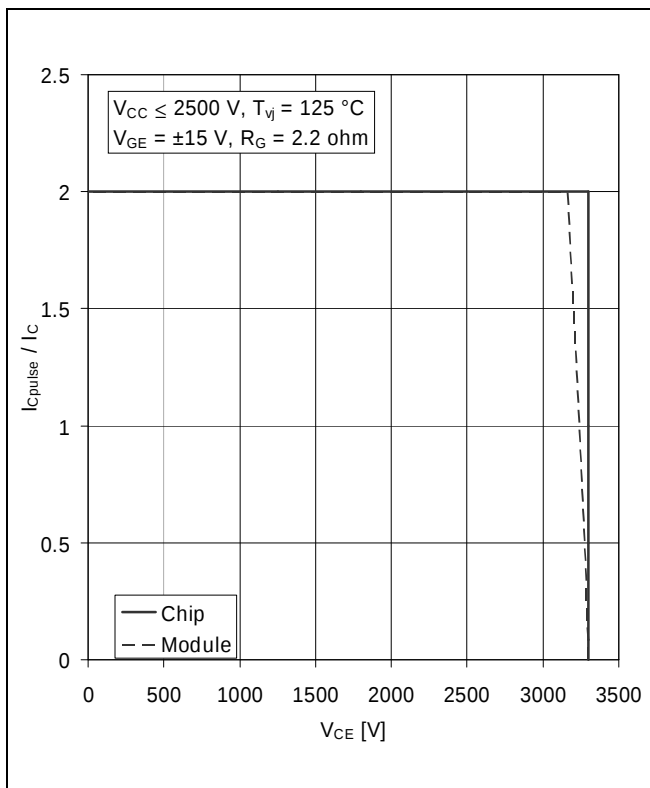


Fig. 11 Turn-off safe operating area (RBSOA)

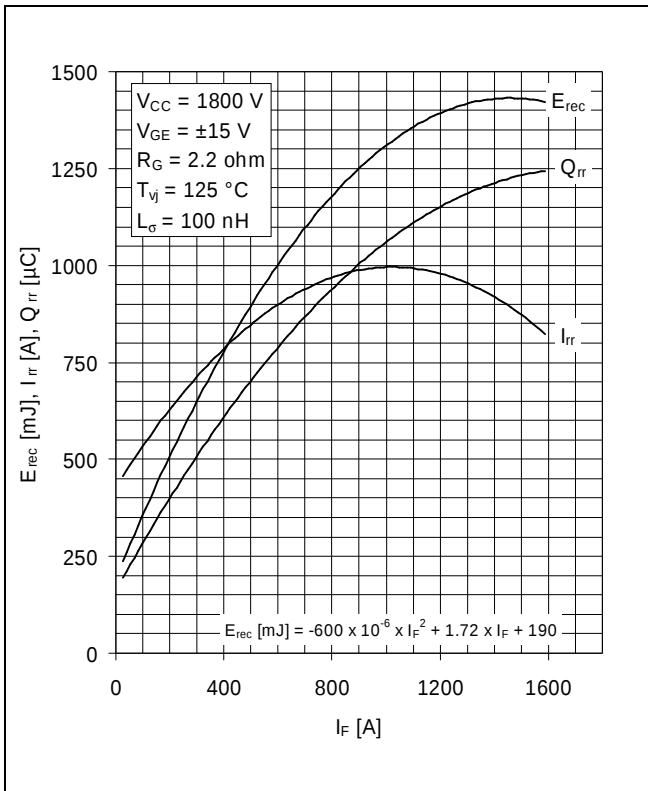


Fig. 12 Typical reverse recovery characteristics vs forward current

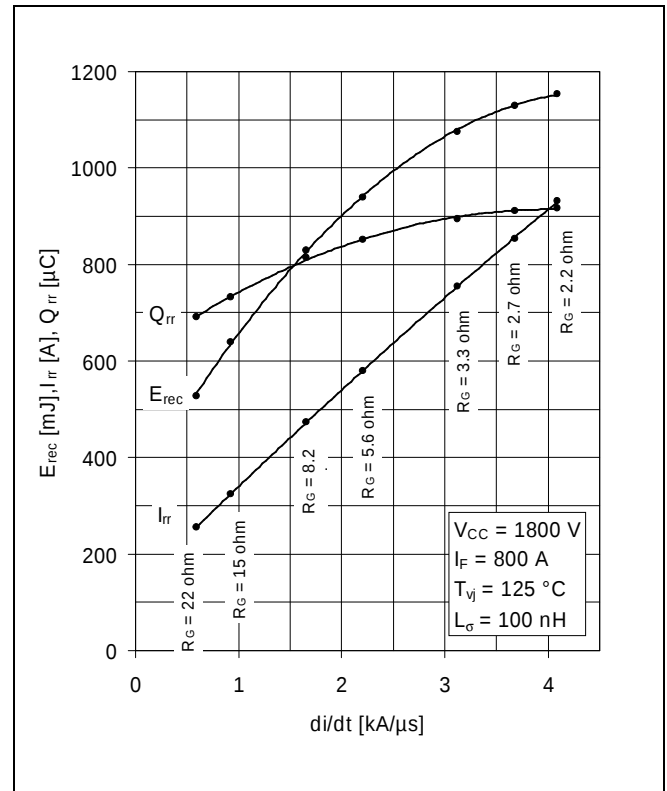


Fig. 13 Typical reverse recovery characteristics vs di/dt

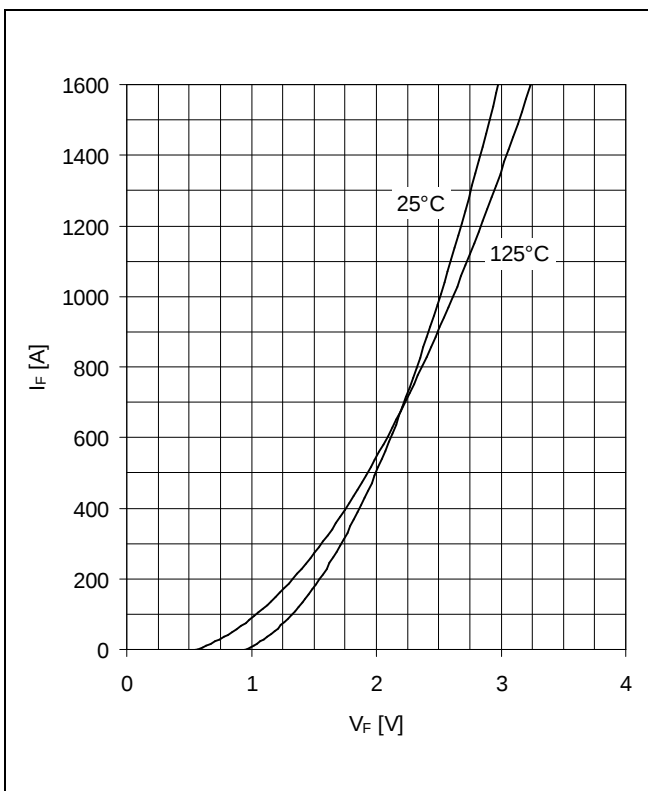


Fig. 14 Typical diode forward characteristics, chip level

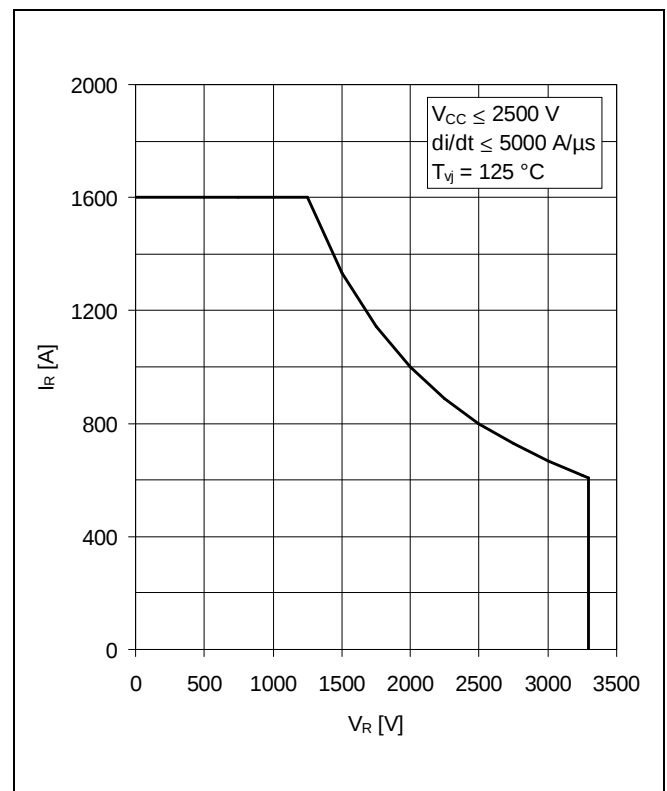


Fig. 15 Safe operating area diode (SOA)

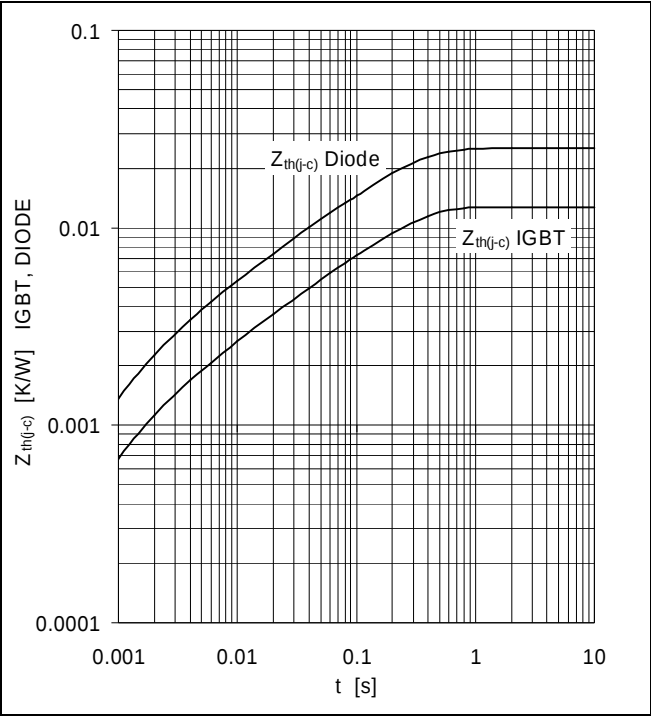


Fig. 16 Thermal impedance vs time

Analytical function for transient thermal impedance:

$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i (1 - e^{-t/t_i})$$

IGBT	i	1	2	3	4	5
	R _i (K/kW)	8.78	2.06	0.961	0.948	
DIODE	τ _i (ms)	207.4	30.1	7.55	1.57	
	R _i (K/kW)	17.3	4.28	1.92	1.92	
	τ _i (ms)	203.6	30.1	7.53	1.57	

ABB Switzerland Ltd, Semiconductors reserves the right to change specifications without notice.



ABB Switzerland Ltd
Semiconductors
Fabrikstrasse 3
CH-5600 Lenzburg, Switzerland

Doc. No. 5SYA1562-01 July 07

Telephone +41 (0)58 586 1419
Fax +41 (0)58 586 1306
Email abbsem@ch.abb.com
Internet www.abb.com/semiconductors